


<b>Search Notes</b>  	<b>Application/Control No.</b>  09853767	<b>Applicant(s)/Patent Under Reexamination</b>  JEAN ET AL.
	<b>Examiner</b>  PHILIP C LEE	<b>Art Unit</b>  2452

### SEARCHED

Class	Subclass	Date	Examiner
709	220,229,223,230,249	1/20/09	/pl/
370	389	1/20/09	/pl/
358	1.15	1/20/02	/pl/

### SEARCH NOTES

Search Notes	Date	Examiner
keywords search in EAST	1/20/09	/pl/
keywords search in 709/220,229,223,230,249;370/389;358/1.15 in EAST	1/20/09	/pl/
Search 709/220,229,223,230,249;370/389;358/1.15 in PG Pub	1/20/09	/pl/
ACM/IEEE Search	1/20/09	/pl/
Google Search	1/20/09	/pl/
Consulted with QAS: Tod Swann regarding the dependent claims 34-36	1/29/09	/pl/

### INTERFERENCE SEARCH

Class	Subclass	Date	Examiner
709	220,229,223,230,249	1/20/09	/pl/
370	389	1/20/09	/pl/
370	1.15	1/20/09	/pl/

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